Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10723664	BURKE ET AL.
Examiner	Art Unit
RICHARD CHAN	2618

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Class	Subclass	Date	Examiner			
455	574, 552.1, 550.1, 572, 343.1	8/1/08	RC			

SEARCH NOTES			
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INTERFERENCE SEARCH			

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